

Notice of References Cited	Application/Control No. 10/808,776	Applicant(s)/Patent Under Reexamination AHN ET AL.	
	Examiner Nam Huynh	Art Unit 2617	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,490,436	12-2002	Kaiwa et al.	455/90.1
*	B	US-6,371,535	04-2002	Wei et al.	292/175
*	C	US-6,785,567	08-2004	Kato, Shoji	455/575.9
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	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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